Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/642,343	GIESSLER ET AL.	
Examiner	Art Unit	
Sara Addisu	3722	

SEARCHED				
Class	Subclass	Date	Examiner	
407	53,54,61	11/16/2005	SA	
408	230,227	11/16/2005	SA	
above	UPDATED	6/6/2006	SA	
above	UPDATED	12/7/2006	SA	
above	UPDATED	8/14/2007	SA	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		-		
	,			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Dan Howell	6/7/2005	SA		
Inventor name search	11/16/2005	SA		
Consulted Hwei Su Payer about restricting claims 11-14 in class 76/108.6. Agreed	6/7/2005	SA		
Consulted H. Payer about treverse to restricting claims 11-14. FIB (focused lon Beam) is known as an alternative to grinding	11/17/2005	SA		
Consulted Dan Howell about rejection and claim language. Dan Howell also did international search	12/5/2006	SA		